# The McGraw-Hill Companies

# **CMOS Digital Integrated Circuits**



# Chapter 5 MOS Inverters: Static Characteristics

S.M. Kang and Y. Leblebici

Copyright © The McGraw-Hill Companies, Inc. Permission required for reproduction or display.

### **Ideal Inverter**



#### **Generic Inverter VTC**



# **Noise Margins**



#### Propagation of digital signals under the influence of noise

# **Noise Margins**



# **Noise Margins**

Nominal output 
$$V_{out} = f(V_{in})$$
 (5.5)

Output under noise 
$$V'_{out} = f(V_{in} + \Delta V_{noise})$$
 (5.6)

$$V'_{out} = f(V_{in}) + \frac{dV_{out}}{dV_{in}} \cdot \Delta V_{noise} + higher order terms (neglected)$$
(5.7)

The nominal operating region is defined as the region where the gain is less than unity !

 $Perturbed Output = Nominal Output + Gain \times External Perturbation$ (5.8)







inversion (switching)  
threshold voltage 
$$V_{th} = \frac{V_{T0,n} + \sqrt{\frac{1}{k_R}} \cdot (V_{DD} + V_{T0,p})}{\left(1 + \sqrt{\frac{1}{k_R}}\right)}$$
(5.71)



nMOS transistor current-voltage characteristics



pMOS transistor current-voltage characteristics



Intersection of current-voltage surfaces of nMOS and pMOS transistors



Intersection of current-voltage surfaces gives the VTC in the voltage plane



How to choose the  $k_R$  ratio to achieve a desired inversion threshold voltage:

$$k_R = \frac{k_n}{k_p} = \left(\frac{V_{DD} + V_{T0,p} - V_{th}}{V_{th} - V_{T0,n}}\right)^2$$
(5.73)

$$\frac{k_n}{k_p} = \frac{\mu_n C_{ox} \cdot \left(\frac{W}{L}\right)_n}{\mu_p C_{ox} \cdot \left(\frac{W}{L}\right)_p} = \frac{\mu_n \cdot \left(\frac{W}{L}\right)_n}{\mu_p \cdot \left(\frac{W}{L}\right)_p}$$
(5.77)



# **Supply Voltage Scaling**



# **Supply Voltage Scaling**



### **CMOS Inverter Layout**





# **CMOS Inverter Layout**

